

Search Notes



Application/Control No.

09/820,457

Examiner

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Applicant(s)/Patent under Reexamination

BORG ET AL.

Art Unit

3629

SEARCHED

Class	Subclass	Date	Examiner
705	1	6/10/05	
	14	5/31/05	DN
340	442		
	448		
399	109		
	113		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
	6/10/05	DN
I US		
EPTO		
PG Pub		
II FOREIGN		
1. EPO		
2. JPO		
3. Patent		
III NPL		
1. Ftext ¹		
2. Ftext ²		
3. Nfext		